**AMENDMENT** 

U.S. Appln. No. 09/989,162

wherein a clearance between an upper face of said cover body and an upper face of said substrate

is set to be 0.5 mm or less.

11. A method for forming a thin film on a substrate by introducing gas to a surface of a

substrate held by a substrate holding device having a cover body which is disposed in an area

surrounding said substrate held by said substrate holding device, said cover body being able to

open and close by rotational movement, by radiating said introduced gas with laser, by

decomposing said introduced gas and then by suctioning and discharging decompositional by-

products, said method comprising:

a step of preventing said gas introduced to said surface of said substrate from being

influenced by outside air,

wherein a clearance between an upper face of said cover body and an upper face of said substrate

is set to be 0.5 mm or less.

Please add the following new claims:

13. The method for forming a thin film according to claim 9, wherein said substrate

holding device is provided with a trench along a circumference of the held substrate and the

introduced gas is able to be discharged through said trench.

14. The method for forming a thin film according to claim 9, wherein a sheet is provided

at a boundary between said held substrate and said substrate holding device.

15. The method for forming a thin film according to claim 11, wherein said substrate

holding device is provided with a trench along a circumference of the held substrate and the

introduced gas is able to be discharged through said trench.

16. The method for forming a thin film according to claim 11, wherein a sheet is

provided at a boundary between said held substrate and said substrate holding device.

2